Se	earch Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/072,622	CHEN ET AL.	
Examiner	Art Unit	
ILIA OUSPENSKI	1644	

SEARCHED				
Class	Subclass	Date	Examiner	
530	350	4/27/2005	I.O.	
514	12	4/27/2005	1.0.	
514	21	4/27/2005	I.O.	
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Sequence search by STIC for I.O.	4/19/2005	I.O.
WEST: attached	4/22/2005	1.0.
Dialog: same as WEST	4/22/2005	1.0.
Inventor search	4/27/2005	1.0.